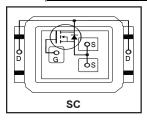
International TOR Rectifier

AUTOMOTIVE GRADE

AUIRL7732S2TR AUIRL7732S2TR1

DirectFFT® Power MOSFFT ②

Bilooti E1 10W	I WOOL ET		
V _{(BR)DSS}	40V		
R _{DS(on)} typ.	5.0m Ω		
max.	6.6m Ω		
I _{D (Silicon Limited)}	58A		
Q _a	22nC		





Logic Level

- Advanced Process Technology
- Optimized for Automotive DC-DC, Motor Drive and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- · Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- · Lead free, RoHS and Halogen free

Applicable DirectFET Outline and Substrate Outline ①

S	В	SC		M2	М4	L4	L6	L8	

Description

The AUIRL7732S2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve low gate charge as well as the lowest on-state resistance in a package that has the footprint which is 38% smaller than an SO-8 and only 0.7mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infrared or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRL7732S2 to offer substantial system level savings and performance improvement specifically in high frequency DC-DC, motor drive and other heavy load applications on ICE, HEV and EV platforms. The AUIRL7732S2 can be utilized together with the AUIRL7736M2 as a control/sync MOSFET pair in a buck converter topology. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units	
V_{DS}	Drain-to-Source Voltage	40	V	
V_{GS}	Gate-to-Source Voltage	± 16	7 V I	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	58		
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	41	T ,	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)3	14	† A	
I _{DM}	Pulsed Drain Current ⑦	230		
P _D @T _C = 25°C	Power Dissipation	41	w	
$P_D @ T_A = 25^{\circ}C$	Power Dissipation 3	2.2		
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ®	46		
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ©	124	mJ mJ	
I _{AR}	Avalanche Current ⑤	See Fig. 18a,18b,16,17	Α	
E _{AR}	Repetitive Avalanche Energy ⑤		mJ	
T _P	Peak Soldering Temperature	260		
TJ	Operating Junction and	-55 to + 175	°C	
T _{STG}	Storage Temperature Range			

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		67	
$R_{\theta JA}$	Junction-to-Ambient ®	12.5]
$R_{\theta JA}$	Junction-to-Ambient 9	20		°C/W
$R_{\theta JCan}$	Junction-to-Can ⊕®		3.7	
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor [®]	C	0.27	

HEXFET® is a registered trademark of International Rectifier.

Static Characteristics @ T_J = 25°C (unless otherwise stated)

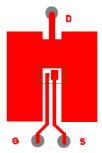
	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.03		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		5.0	6.6	mΩ	V _{GS} = 10V, I _D = 35A ⑦
			7.5	10.5		V _{GS} = 4.5V, I _D = 29A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	1.0	1.8	2.5	V	$V_{DS} = V_{GS}$, $I_D = 50\mu A$
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-7.1		mV/°C	$V_{DS} = V_{GS}, I_D = 30\mu A$
gfs	Forward Transconductance	64			S	$V_{DS} = 10V, I_{D} = 35A$
R_{G}	Gate Resistance		0.64		Ω	
I _{DSS}	Drain-to-Source Leakage Current			5	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
		_		250		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V

Dynamic Characteristics @ T_J = 25°C (unless otherwise stated)

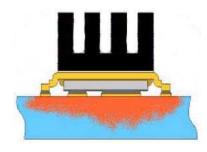
	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		22	33		V _{DS} = 20V
Q _{gs1}	Pre-Vth Gate-to-Source Charge		3.3			$V_{GS} = 4.5V$
Q _{gs2}	Post-Vth Gate-to-Source Charge		2.8		nC	I _D = 35A
Q_{gd}	Gate-to-Drain ("Miller") Charge		13			See Fig.11
Q_{godr}	Gate Charge Overdrive		2.9			
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		15.8			
Q _{oss}	Output Charge		13		nC	$V_{DS} = 16V, V_{GS} = 0V$
t _{d(on)}	Turn-On Delay Time		21			$V_{DD} = 20V, V_{GS} = 4.5V$ ⑦
t _r	Rise Time		123		ns	I _D = 35A
t _{d(off)}	Turn-Off Delay Time		22			$R_G = 6.8\Omega$
t _f	Fall Time		37			
C _{iss}	Input Capacitance		2020			$V_{GS} = 0V$
C _{oss}	Output Capacitance		410			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		210		pF	f = 1.0MHz
Coss	Output Capacitance		1460			$V_{GS} = 0V, V_{DS} = 1.0V, f=1.0MHz$
C _{oss}	Output Capacitance		365			$V_{GS} = 0V, V_{DS} = 32V, f=1.0MHz$
C _{oss} eff.	Effective Output Capacitance		630			$V_{GS} = 0V$, $V_{DS} = 0V$ to $32V$

Diode Characteristics @ T_J = 25°C (unless otherwise stated)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)			58		MOSFET symbol showing the	
I _{SM}	Pulsed Source Current (Body Diode) ^⑤	_		230		integral reverse p-n junction diode.	G S
V_{SD}	Diode Forward Voltage	_		1.3	V	$I_S = 35A, V_{GS} = 0V$ ⑦	
t _{rr}	Reverse Recovery Time		23	35	ns	$I_F = 35A, V_{DD} = 20V$	
Q _{rr}	Reverse Recovery Charge	_	16	24	nC	di/dt = 100A/µs ⑦	



③ Surface mounted on 1 in. square Cu (still air).



Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

Qualification Information[†]

		Automotive			
Qualification Level		(per AEC-Q101) †† Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity	Level	SMALL-CAN	MSL1, 260°C		
	Machine Model	Class M4 (+/- 425V) ^{†††}			
ESD	Human Body Model	AEC-Q101-002 Class H1B (+/- 1000V) ^{†††} AEC-Q101-001			
	Charged Device	N/A			
	Model	AEC-Q101-005			
RoHS Compliant		Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com

www.irf.com 3

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.

^{†††} Highest passing voltage.

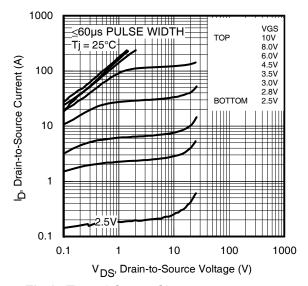
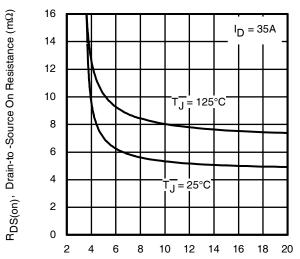


Fig 1. Typical Output Characteristics



 $\label{eq:VGS} \mbox{\sc Voltage (V)} \mbox{\sc Fig 3.} \mbox{\sc Typical On-Resistance vs. Gate Voltage}$

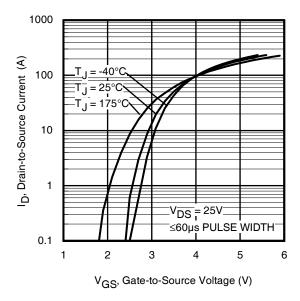


Fig 5. Typical Transfer Characteristics

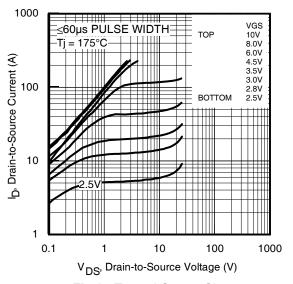


Fig 2. Typical Output Characteristics

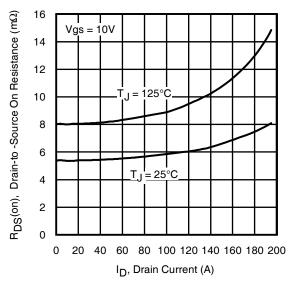


Fig 4. Typical On-Resistance vs. Drain Current

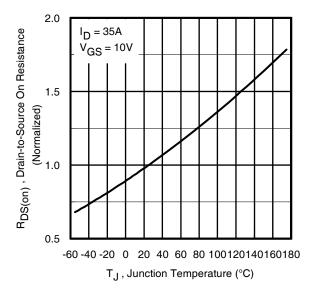
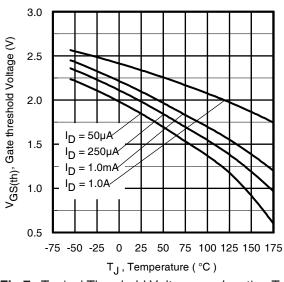


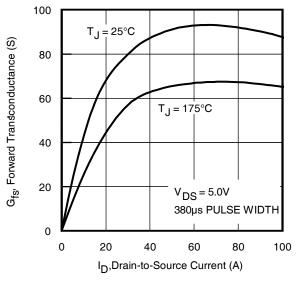
Fig 6. Normalized On-Resistance vs. Temperature www.irf.com



1000 I_{SD}, Reverse Drain Current (A) 100 TJ = -40°C $TJ = 25^{\circ}C$ $T_{J} = 175^{\circ}C$ 10 GS = 0V1.0 0.0 0.2 0.4 0.6 8.0 1.2 1.0 V_{SD}, Source-to-Drain Voltage (V)

Fig 7. Typical Threshold Voltage vs. Junction Temperature

Fig 8. Typical Source-Drain Diode Forward Voltage



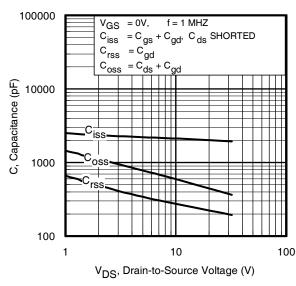
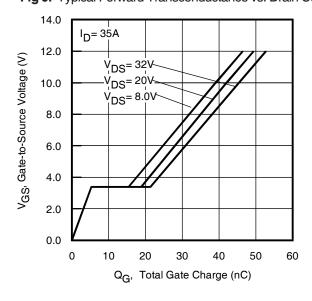


Fig 9. Typical Forward Transconductance vs. Drain Current

Fig 10. Typical Capacitance vs. Drain-to-Source Voltage



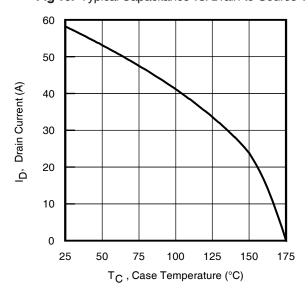


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com

Fig 12. Maximum Drain Current vs. Case Temperature 5

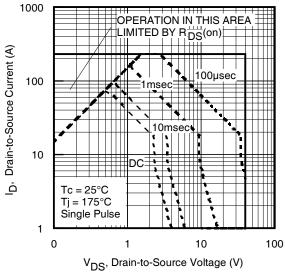


Fig 13. Maximum Safe Operating Area

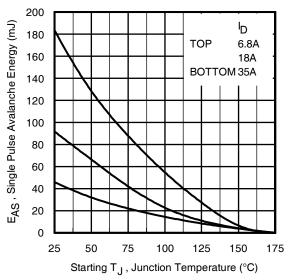


Fig 14. Maximum Avalanche Energy vs. Temperature

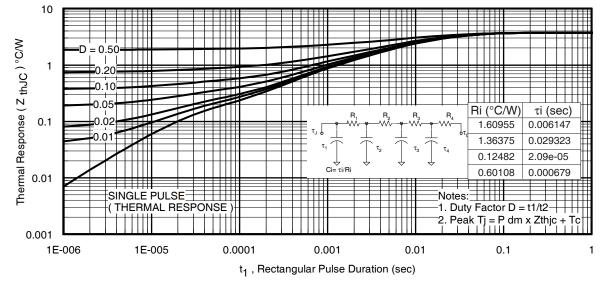


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

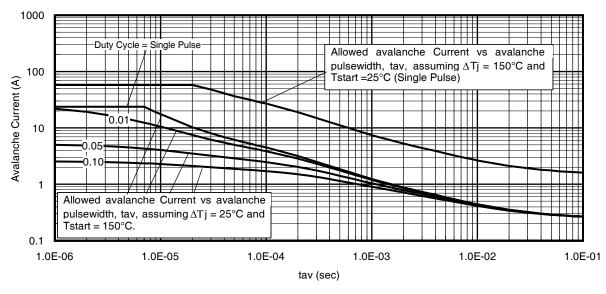


Fig 16. Typical Avalanche Current vs. Pulsewidth

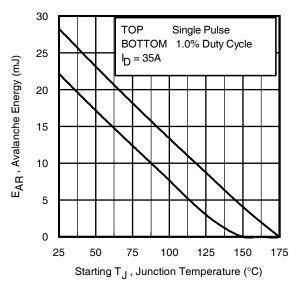


Fig 17. Maximum Avalanche Energy vs. Temperature

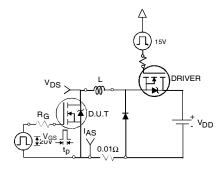


Fig 18a. Unclamped Inductive Test Circuit

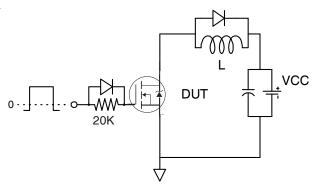


Fig 19a. Gate Charge Test Circuit

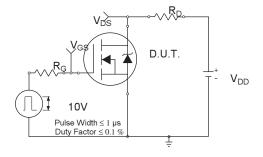


Fig 20a. Switching Time Test Circuit

Notes on Repetitive Avalanche Curves , Figures 16, 17: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,IC}(D, t_{av})$ = Transient thermal resistance, see figure 15)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot BV \cdot I_{aV}) = \Delta T/\text{ } Z_{thJC} \\ I_{av} &= 2\Delta T/\text{ [} 1.3 \cdot BV \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

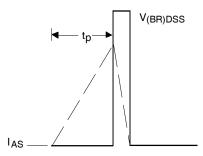


Fig 18b. Unclamped Inductive Waveforms

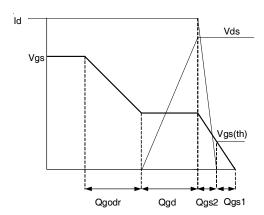


Fig 19b. Gate Charge Waveform

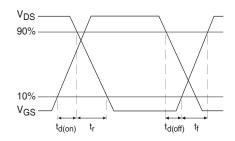
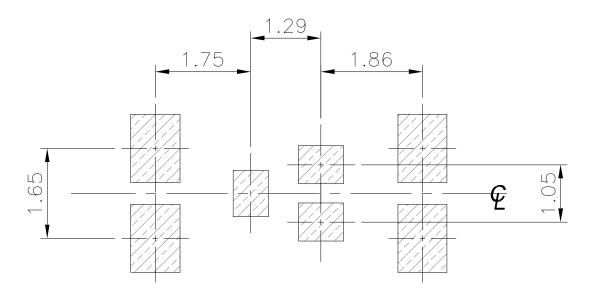
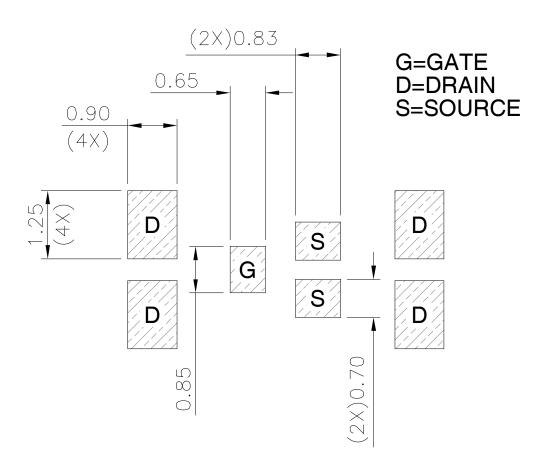


Fig 20b. Switching Time Waveforms

Automotive DirectFET® Board Footprint, SC (Small Size Can).

Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations

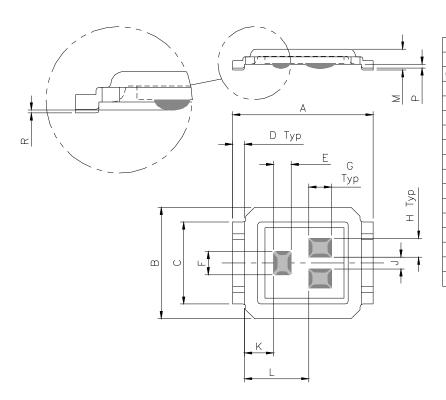




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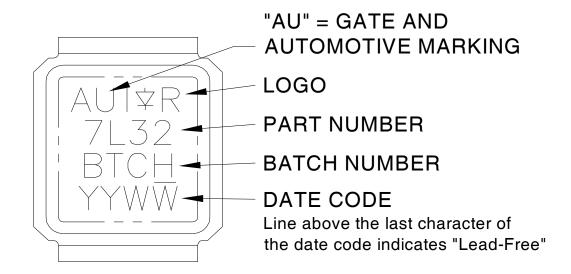
Automotive DirectFET® Outline Dimension, SC Outline (Small Size Can).

Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations

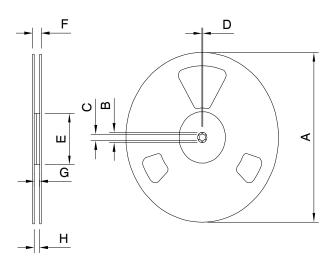


DIMENSIONS								
	MET	ETRIC IMPERIAL						
CODE	MIN	MAX	MIN	MAX				
Α	4.75	4.85	0.187	0.191				
В	3.70	3.95	0.146	0.156				
O	2.75	2.85	0.108	0.112				
D	0.35	0.45	0.014	0.018				
Е	0.58	0.62	0.023	0.024				
F	0.78	0.82	0.031	0.032				
G	0.75	0.80	0.030	0.031				
Η	0.63	0.67	0.025	0.026				
J	0.38	0.42	0.015	0.016				
K	0.95	1.05	0.037	0.041				
٦	2.15	2.25	0.085	0.088				
М	0.68	0.74	0.027	0.029				
Р	0.08	0.17	0.003	0.007				
R	0.02	0.08	0.001	0.003				

Automotive DirectFET® Part Marking

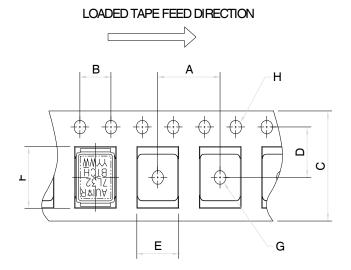


Automotive DirectFET® Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as AUIRL7732S2TR). For 1000 parts on 7" reel, order AUIRL7732S2TR1

	REEL DIMENSIONS								
S	TANDARI	OPTION	V (QTY 48	(00)	TR	1 OPTION	(QTY 10	00)	
	ME	TRIC	IMP	ERIAL	ME	TRIC	IMP	ERIAL	
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
Е	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Η	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C	



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS							
	ME	TRIC	IMPERIAL				
CODE	MIN	MAX	MIN	MAX			
Α	7.90	8.10	0.311	0.319			
В	3.90	4.10	0.154	0.161			
С	11.90	12.30	0.469	0.484			
D	5.45	5.55	0.215	0.219			
Е	4.00	4.20	0.158	0.165			
F	5.00	5.20	0.197	0.205			
G	1.50	N.C	0.059	N.C			
Н	1.50	1.60	0.059	0.063			

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- 3 Surface mounted on 1 in. square Cu board, steady state.
- $\ensuremath{\mathfrak{G}}$ T_C measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25^{\circ}C$, L = 0.075mH, $R_G = 50\Omega$, $I_{AS} = 35A$, Vgs = 16V.
- Pulse width $\le 400 \mu s$; duty cycle $\le 2 \%$.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $^{\circledR}$ R_{θ} is measured at T_J of approximately 90°C.

International

TOR Rectifier

AUIRL7732S2TR/TR1

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For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

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